

Application/Control No.	Applicant(s)/Patent under Reexamination	_
09/752,073	SCHIER, JOHN E.	
Examiner	Art Unit	_
Tri H. Phan	2661	

SEARCHED				
Class	Subclass	Date	Examiner	
379	88.13, 201.01, 201.02, 201.05	6/30/2004	TP	
370	493-495	6/30/2004	TP	
370	419	6/30/2004	TP	
375	222	3/23/2005	TP	
713	200-202	3/23/2005	TP	
Updated	search	10/28/2005	TP	
Updated	search	2/3/2006	TP	

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
PGPub te February 3 interferen	,2006; see	2/3/2006	TP		

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST, IEEE, Internet search	6/30/2004	ТР
Consulted with Brian Nguyen (Pri)	3/23/2005	TP
Consulted with Frank Duong (Pri)	10/28/2005	TP
Inventorship search	10/28/2005	TP
370/509,535; 713/200 (text search only - see search history printout)	2/2/2003	TP
Consulted with Chau T. Nguyen (SPE)	2/2/2003	TP